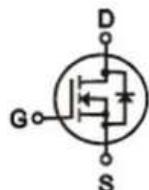
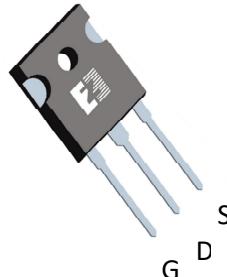


• General Description

It combines planar MOSFET technology with a low resistance package to provide low $R_{DS(ON)}$.

• Product Summary

 $V_{DS} = 60V$
 $R_{DS(ON)} = 9.5m\Omega$
 $I_D = 148A$
• Features

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance


• Application

- BLDC Motor driver
- DC-DC
- Load Switch

TO-247


• Ordering Information:

Part NO.	ZMPA090N06HC			
Marking	ZMP090N06H			
Packing Information	TUBE			
Basic ordering unit (pcs)	400			

• Absolute Maximum Ratings ($T_C=25^\circ C$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		60	V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_C=25^\circ C$	148	A
	I_D	$T_C=75^\circ C$	121	A
	I_D	$T_C=100^\circ C$	105	A
Pulsed Drain Current ^①	I_{DM}	Pulsed; $t_p \leq 10 \mu s$; $T_{mb} = 25^\circ C$	444	A
Total Power Dissipation	P_D	$T_C=25^\circ C$	484	W
Total Power Dissipation	P_D	$T_A=25^\circ C$	3.8	W
Operating Junction Temperature	T_J		-55 to +175	$^\circ C$
Storage Temperature	T_{STG}		-55 to +175	$^\circ C$
Single Pulse Avalanche Energy	E_{AS}	$L=0.5mH$, $VGS=10V$, $Rg=25\Omega$,	2580	mJ
ESD Level (HBM)			CLASS 2	

•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}		-	0.31	°C/W
Thermal resistance, junction-ambient	R _{thJA} ①		-	40	°C/W
Soldering temperature (total time<10s)	T _{sold}		-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	60			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250μA	2	2.6	4	V
Drain-Source Leakage Current	I _{DSS}	V _{GS} =0V, V _{DS} = 60V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} = 0V			100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =10V, I _D = 20A		9.5	11	mΩ
Forward Transconductance	g _{FS}	V _{DS} =11.2V, I _D = 7.5A		21		S
Diode Forward Voltage	V _{FSD}	V _{GS} =0V, I _{SD} = 20A			1.3	V

•Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz, V _{DS} =25V	-	7350	-	pF
Output capacitance	C _{oss}		-	1290	-	
Reverse transfer capacitance	C _{rss}		-	142	-	
Gate Resistance	R _g	f = 1MHz	-	1.4		Ω
Total gate charge	Q _g	V _{DD} = 15V, I _D = 20A, V _{GS} = 10V	-	138	-	nC
Gate - Source charge	Q _{gs}		-	26.7	-	
Gate - Drain charge	Q _{gd}		-	31.8	-	
Turn-ON Delay time	t _{D(on)}	V _{GS} =10V, V _{DS} =15V, R _G =3.3Ω, I _D =20A	-	25	-	ns
Turn-ON Rise time	t _r		-	73	-	ns
Turn-Off Delay time	t _{D(off)}		-	93	-	ns
Turn-Off Fall time	t _f		-	32	-	ns
Reverse Recovery Time	t _{rr}	V _{DD} =20V, dI _S /dt = 100A/us, I _S =50A	-	95	-	ns
Reverse Recovery Charge	Q _{rr}		-	250	-	nC

Fig.1 Gate-Charge Characteristics

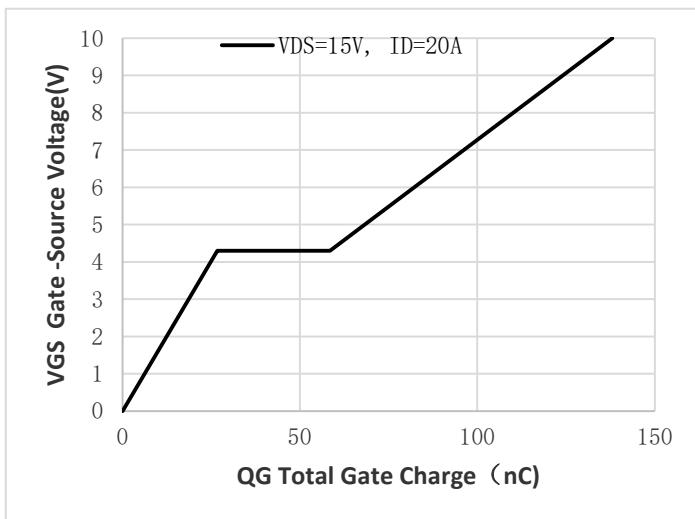


Fig.2 Capacitance Characteristics

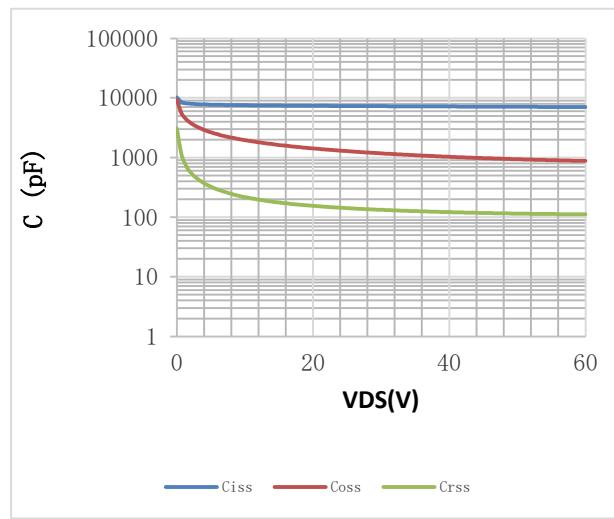


Fig.3 Power Dissipation

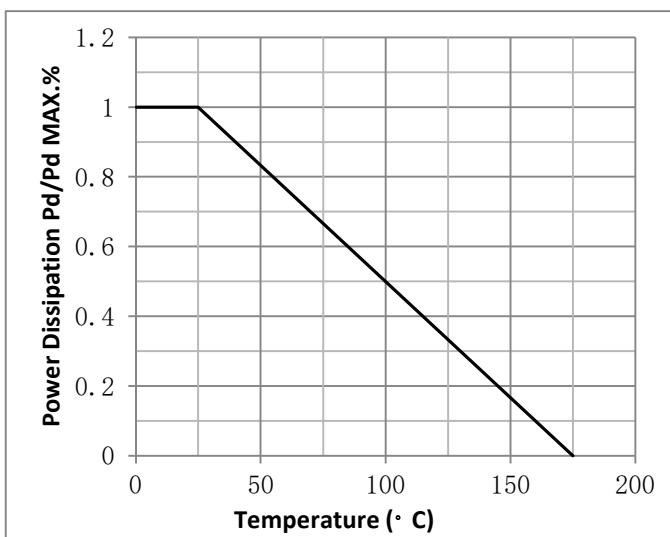


Fig.4 Typical output Characteristics

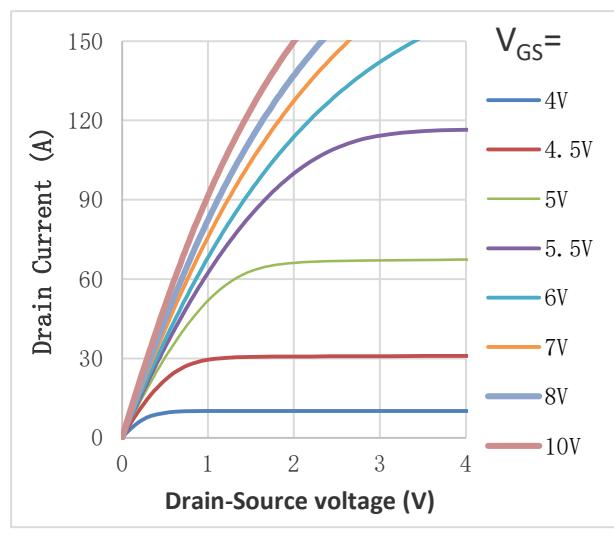


Fig.5 Threshold Voltage V.S Junction Temperature

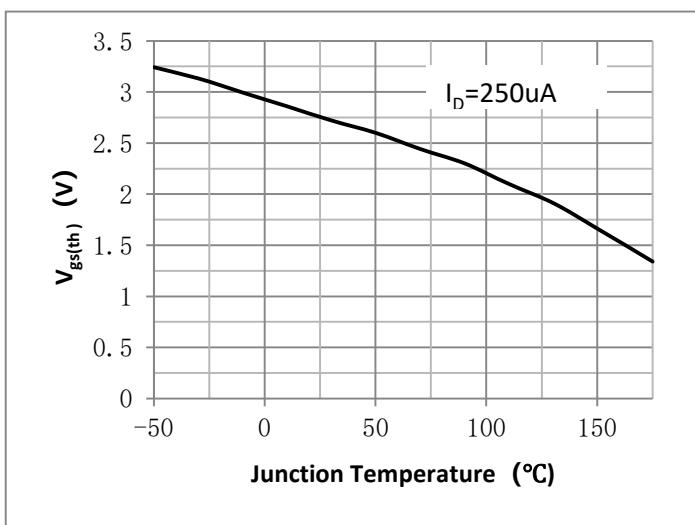


Fig.6 Resistance V.S Drain Current

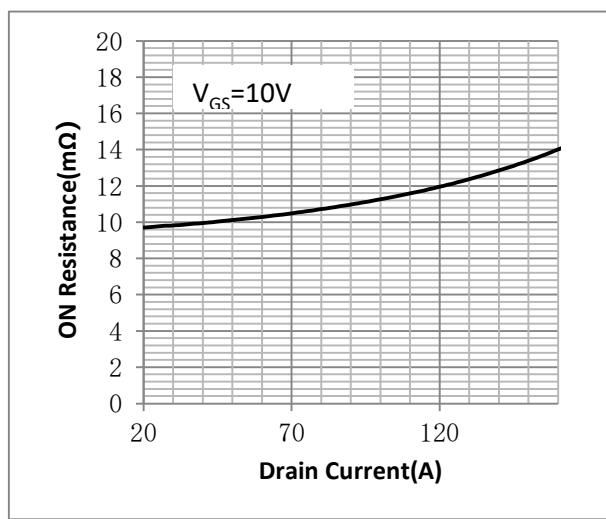


Fig.7 On-Resistance VS Gate Source Voltage

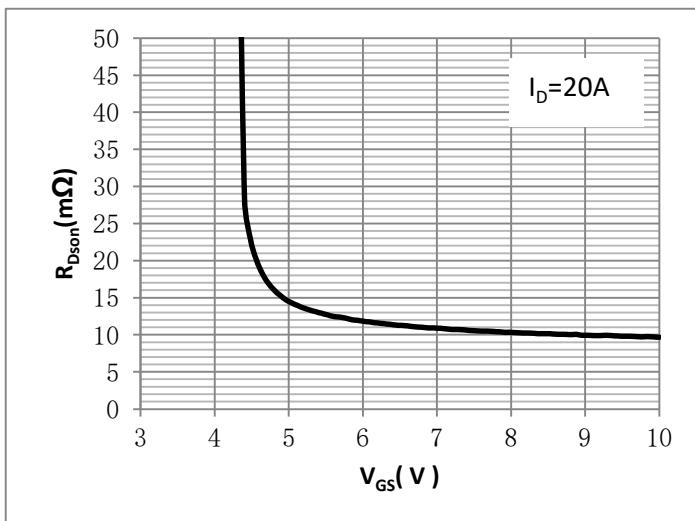


Fig.8 On-Resistance V.S Junction Temperature

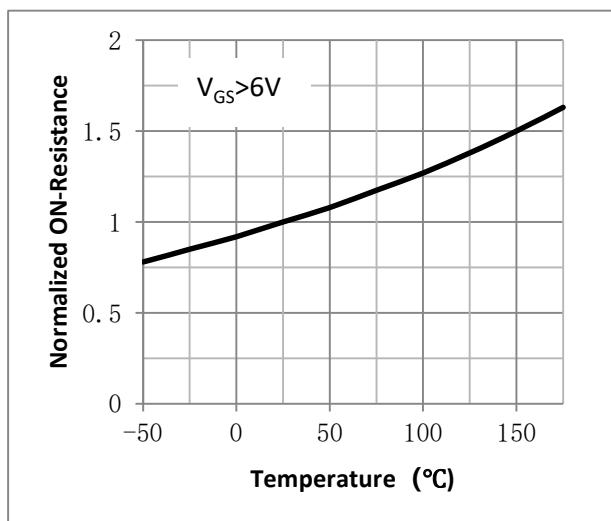


Figure 9. Diode Forward Voltage vs. Current

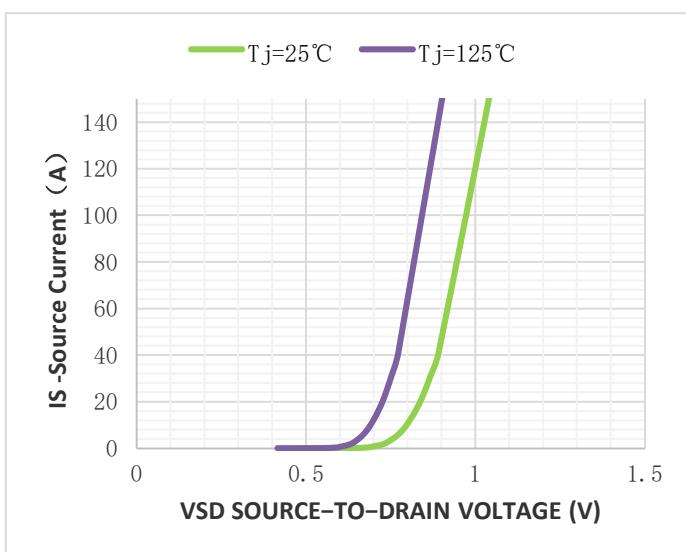


Figure 10. Transfer Characteristics

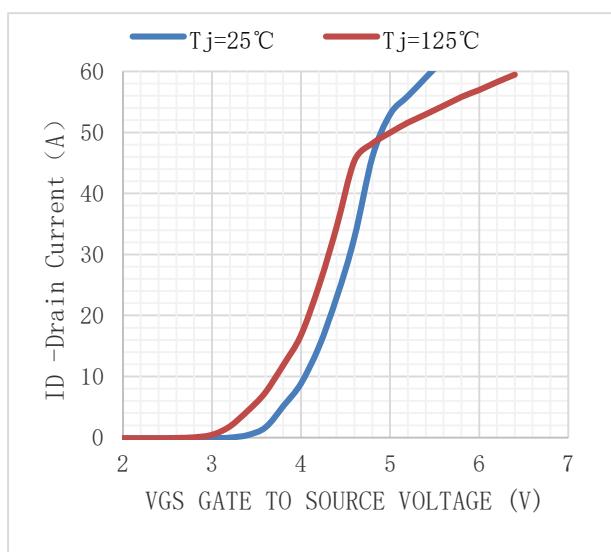


Fig.11 SOA Maximum Safe Operating Area

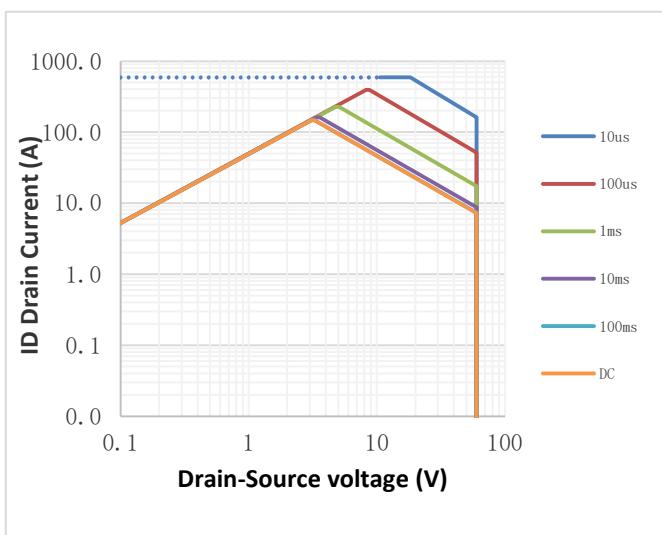
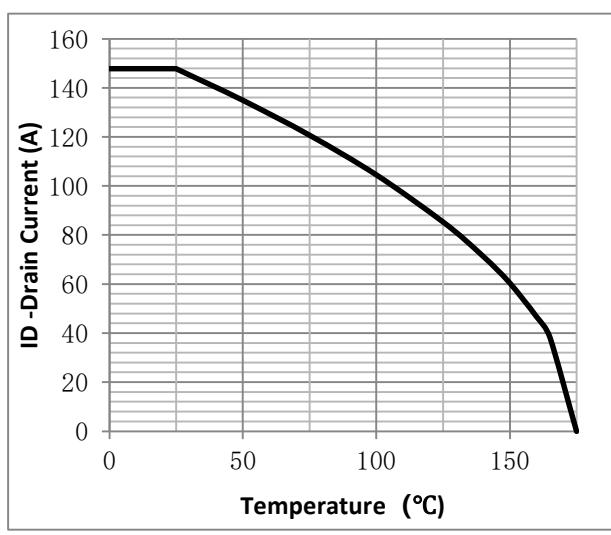
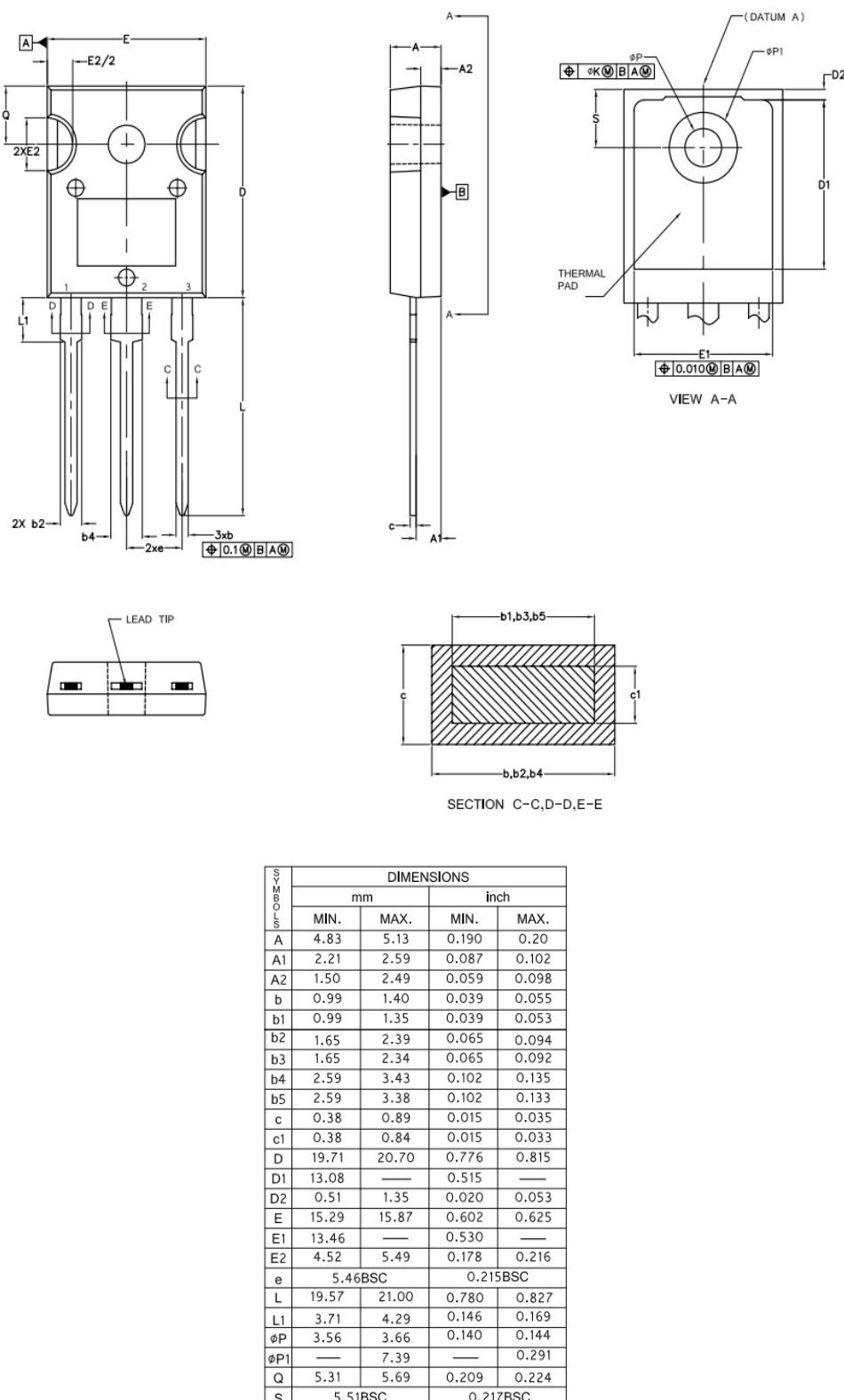


Fig.12 ID vs. Junction Temperature②



•TO-247 Package Outline


Note:

- ① Pulse : VGS=+20V/-20V, Duty cycle=50%,Tj=175°C, t=1000 hours; For DC , the following test conditions can be passed: VGS=+20V/-10V, Tj=175°C, t=1000 hours;
- ② Practically the current will be limited by PCB, thermal design and operating temperature. VGS=10V.

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Revision History

Version	Date	Change
A	2025/2/25	New